

Search Notes

Application/Control No.

10/760,414

Examiner

Khiem Nguyen

Applicant(s)/Patent under
Reexamination

BENHAM, JOHN

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	63	2/15/2005	KN
↓	578	↓	↓
	579		
	581		
	582		
	638		
↓	912	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
All	Sub-class	2/21/2005	KN
Search	Above		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR